

Solutions Exercises Week 4

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Exercise 1.

a)

The quantum dot is excited with a repetition period of 6 ns like we see in Fig. 1. The photoluminescence of course has the same periodicity like we see in Fig. 2. The decay is not a simple exponential decay but has two components.

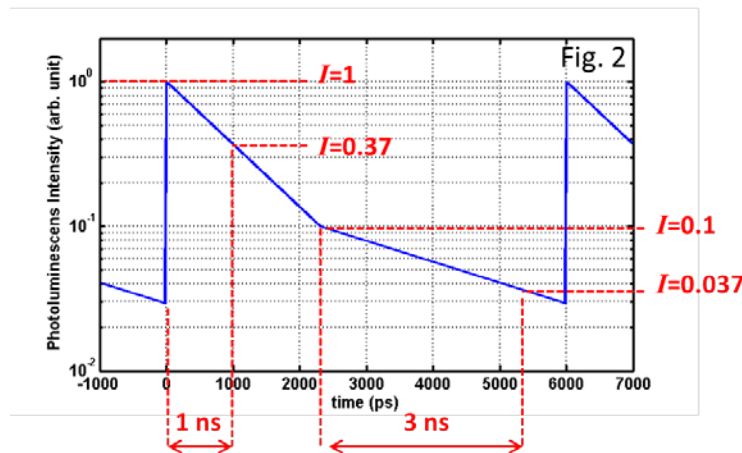
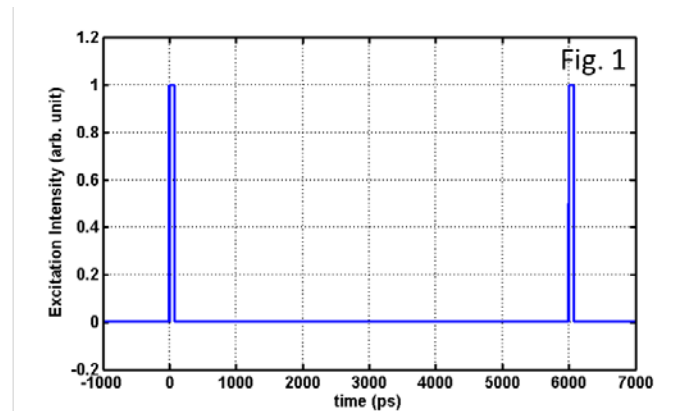
$$I = I_1 e^{-t/\tau_1} \quad \text{for } 0 < t < 2300 \text{ ps}$$

$$I = I_2 e^{-t/\tau_2} \quad \text{for } 2300 < t < 6000 \text{ ps}$$

In the time period $t = 0$ to $t = \tau_1$ the intensity falls from 1 to $e^{-\tau_1/\tau_1} = e^{-1} = 0.37$

The decay time is thus $\tau_1 = 1 \text{ ns}$. See Fig. 2

In the same way $\tau_2 = 3 \text{ ns}$. See Fig. 2



b)

The fastest measured component of the decay was roughly 1 ns. Now we must check how fast our diode is. If the response time is on the same time scale there is a chance that the measured decay is erroneous. The real decay could be much faster, it is just that we can't measure it.

The response time of a pin photodiode is limited by the RC constant and the drift time. We can ignore the diffusion time since most of the absorption in a pin diode happens in the intrinsic region where we have an electric field separating the charge carriers quickly.

RC

The pin diode can be approximated by a plate capacitor (see Fig 3)

$$C = \epsilon_r \epsilon_0 \frac{A}{W} = 11.9 * 8.85 * 10^{-12} * \frac{\pi(0.5 * 10^{-3})^2}{25 * 10^{-6}} = 3.3 \text{ pF}$$

Where A is the area of the device, W is the length of the intrinsic region.

ϵ_r and ϵ_0 are the relative and vacuum permittivity. ϵ_r for Si is found among the material parameters given in the question. ϵ_0 can be found in any formula book or at the back cover of "Fundamentals of Photonics".

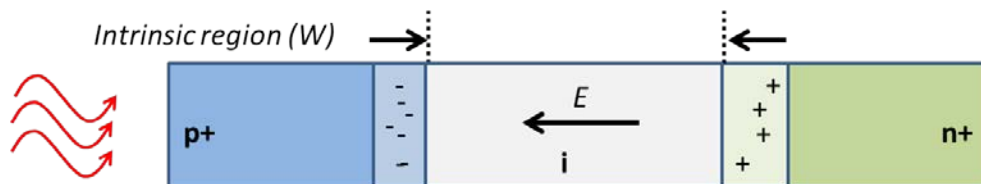


Fig. 3

The RC constant is thus $RC = 50\Omega * 3.3 \text{ pF} = 50 * 3.3 * 10^{-12} = 170 \text{ ps}$

Drift time

To calculate the drift time you need to know the electric field. You can then calculate it from the mobility or get it from a graph like the one given in the exercise. Note that the drift velocity saturates at high fields.

$$F = \frac{5 \text{ V}}{25 \mu\text{m}} = 2 * 10^5 \text{ V/m} = 2 * 10^3 \text{ V/cm}$$

[From drift velocity chart, assuming the same drift velocity for electrons and holes, assuming T=300K]

$$\Rightarrow v_{drift} = 3 * 10^6 \text{ cm/s} = 3 * 10^4 \text{ m/s}$$

$$\Rightarrow \tau_{drift} = \frac{W}{v_{drift}} = \frac{25 * 10^{-6}}{3 * 10^4} = 830 \text{ ps}$$

Ans: The RC constant is fine but the drift time is quite close to the fastest decay time 1 ns. It is likely that the measured decay time is affected by the slow response of the photodiode.

c)

The drift velocity $3 * 10^4 \text{ m/s}$. There is still room to improve it by a factor 3 by increasing reverse bias and thereby reducing the drift time.

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$$\mathfrak{R} = G\eta \frac{\lambda[\mu m]}{1.24}$$

We are here working with a detector with ideal quantum efficiency, $\eta = 1$, and unity gain, $G = 1$.

The ideal responsivity will then rise linearly up to the bandgap wavelength, λ_g . See red trace in Fig. 4

Responsivity (A/W)

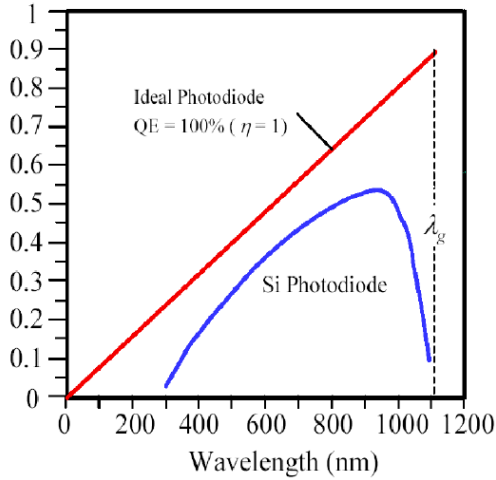


Fig. 4

- a) $\lambda_g(Si) = 1.11\mu m \Rightarrow \mathfrak{R}_{max} = \frac{1.11}{1.24} = 0.90 \text{ A/W}$
- b) $\lambda_g(GaAs) = 0.873\mu m \Rightarrow \mathfrak{R}_{max} = \frac{0.873}{1.24} = 0.70 \text{ A/W}$
- c) $\lambda_g(InSb) = 7.29\mu m \Rightarrow \mathfrak{R}_{max} = \frac{7.29}{1.24} = 5.9 \text{ A/W}$

Note that this is a simplified picture. In reality the maximum responsivity lies at shorter wavelength than the bandgap. This is because close to the bandgap the absorption coefficient is quite small giving a reduced η . Compare the blue and red trace in Fig. 4.

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At steady state $\Delta n = R\tau$

Where R is the generation rate and τ is the recombination lifetime.

Calculate R:

PD = power density

$R = \text{generated carriers/s} = PD * \eta / (hc/\lambda)$

Calculate photogenerated carrier concentration:

$$\Delta n = R\tau = \frac{PD * \eta * \lambda * \tau}{hc} = \frac{10^{-3} * 0.5 * 10^{-6} * 10 * 10^{-6}}{hc} = 2.5 * 10^{10} \text{ cm}^{-3}$$
$$\Rightarrow \frac{\Delta n}{n_i} = \frac{2.5 * 10^{10}}{1.5 * 10^{10}} = 167\%$$

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Calculate quantum efficiency:

$$\eta = \frac{\text{collected electrons}}{\text{incoming photons}} = \frac{2 * 10^{12}}{6 * 10^{12}} = 1/3$$

Calculate quantum responsivity:

$$\mathfrak{R} = \eta \frac{\lambda[\mu m]}{1.24} = \frac{1}{3} * \frac{1.55}{1.24} = 0.42 \text{ A/W}$$

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Calculate quantum efficiency:

$$\mathfrak{R} = G\eta \frac{\lambda[\mu m]}{1.24} \Rightarrow$$
$$\Rightarrow \eta = \frac{\mathfrak{R} * 1.24}{G * \lambda[\mu m]} = \frac{12 * 1.24}{20 * 1.55} = 0.48$$

Calculate photocurrent:

$$I = \eta Ge\Phi = 0.48 * 20 * 1.6 * 10^{-19} * 10^{10} = 15 \text{ nA}$$

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The photogenerated current is

$$\bar{i} = eG\eta\phi = e * 100 * 0.8 * \frac{10 * 10^{-9}}{\left(\frac{1240}{870}\right) * e} = 560 \text{ nA}$$

The variance of this current (arising from photon shot noise, gain and the excess noise factor) is

$$\sigma_i^2 = 2eB\bar{i}GF$$

So we need to calculate the excess noise factor, F , which depends on the gain and on the ionization ratio. If k is close to 1 both electrons and holes contribute to gain via impact ionization. This means that the avalanche doesn't just go in one direction.

$$F = k * \bar{G} + (1 - k) \left(2 - \frac{1}{\bar{G}} \right) = 51$$

\Rightarrow

$$\sigma_i^2 = 2eB\bar{i}GF = 2e * 100 * 10^3 * \bar{i} * 100 * 51 \Rightarrow \sigma_i = 9.6 \text{ nA}$$

The dark current has the same shot noise variance as the photo generated current. Again the variance is increased by the excess noise factor

$$\bar{i}_{Dark} = 1 \text{ nA}$$

$$\sigma_{iDark}^2 = 2eB\bar{i}_{Dark}GF = 2e * 100 * 10^3 * \bar{i}_{Dark} * 100 * 51 \Rightarrow \sigma_{iDark} = 0.40 \text{ nA}$$

Finally we have Johnson-Nyquist noise due to thermal motion of carriers in the leads.

$$\sigma_{JN}^2 = \frac{4k_B T B}{R} = \frac{4k_B * 300 * 100 * 10^3}{10^3} \Rightarrow \sigma_{JN} = 1.3 \text{ nA}$$

We see that the photocurrent noise dominates over the two other terms so we are in the photon shot noise limited regime.

The total signal to noise ratio is:

$$SNR = \frac{\bar{i}^2}{\sigma_i^2 + \sigma_{iDark}^2 + \sigma_{JN}^2} = 3400$$

Answer: The total SNR is 3400 based on

Photocurrent RMS= 9.6 nA

Dark current RMS= 0.40 nA

Johnson-Nyquist RMS= 1.3 nA